

wafer

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the main question of interest is whether the presense of particles on the wafer affects the quality outcome. Generate a data frame for the data.

```
y <- c(320, 14, 80, 36)
particle <- gl(2, 1, 4, labels=c("no","yes"))
quality <- gl(2, 2, 4, labels=c("good","bad"))
(wafer <- data.frame(y, particle, quality))
```

```
##      y particle quality
## 1 320      no    good
## 2  14     yes    good
## 3  80      no    bad
## 4  36     yes    bad
```

```
# view the data frame as a table
(ov <- xtabs(y ~ quality + particle))
```

```
##           particle
## quality no yes
##   good 320 14
##   bad  80 36
```

multinomial model

```
# marginal proportions for particle values
(pp <- prop.table( xtabs(y ~ particle)))
```

```
## particle
##           no           yes
## 0.8888889 0.1111111
```

```
# marginal proportions for quality values
(qp <- prop.table( xtabs(y ~ quality)))
```

```
## quality
##           good          bad
## 0.7422222 0.2577778
```

```
# fitted values, mu_ij
(fv <- outer(qp,pp)*450)
```

```
##      particle
## quality      no      yes
##    good 296.8889 37.11111
##    bad  103.1111 12.88889
```

```
# deviance (on 1 d.f.)
2*sum(ov*log(ov/fv))
```

```
## [1] 54.03045
```

```
pchisq(54.03, 1, lower.tail=FALSE)
```

```
## [1] 1.974517e-13
```

poisson model

```
mod1 <- glm(y ~ particle + quality, poisson)
deviance(mod1)
```

```
## [1] 54.03045
```

```
# pearson's chisquared stat
sum(residuals(mod1, type="pearson")^2)
```

```
## [1] 62.81231
```